8-Pin DIP High Speed Transistor Optocouplers

Single-Channel: 6N135M, 6N136M, HCPL4503M Dual-Channel: HCPL2530M, HCPL2531M

Description

The 6N135M, 6N136M, HCPL4503M, HCPL2530M, and HCPL2531M optocouplers consist of an AlGaAs LED optically coupled to a high speed photodetector transistor for each channel.

A separate connection for the bias of the photodiode improves the speed by several orders of magnitude over conventional phototransistor optocouplers by reducing the base-collector capacitance of the input transistor.

The HCPL4503M has no internal connection to the phototransistor base for improved noise immunity. An internal noise shield provides superior common mode rejection of up to $50,000 \text{ V/}\mu\text{s}$.

Features

- High Speed 1 MBit/s
- Dual-Channel: HCPL2530M, HCPL2531M
- CTR Guaranteed 0°C to 70°C
- No Base Connection for Improved Noise Immunity (HCPL4503M)
- Superior CMR of 15,000 V/μs Minimum (HCPL4503M)
- Safety and Regulatory Approvals
 - ◆ UL1577, 5,000 VAC_{RMS} for 1 Minute
 - ◆ DIN EN/IEC60747-5-5
- These are Pb-Free Devices

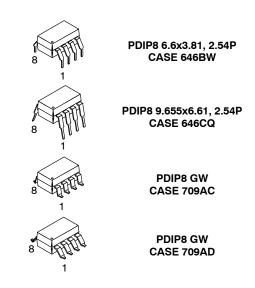
Applications

- Line Receivers
- Pulse Transformer Replacement
- Output Interface to CMOS-LSTTL-TTL
- Wide-Bandwidth Analog Coupling

Related Resources

- https://www.onsemi.com/products/interfaces/high-performance-opto-ouplers
- https://www.onsemi.com/products/interfaces/high-performance-opto couplers/high-performance-transistor-optocouplers/hcpl0500
- https://www.onsemi.com/products/interfaces/high-performance-optocouplers/high-performance-optocouplers/fodm452
- https://www.onsemi.com/products/interfaces/high-performance-optocouplers/fod050l

1



MARKING DIAGRAM



6N135 = Device Number

V = DIN EN/IEC60747-5-5 Option (only appears on component ordered with this option)

XX = Two Digit Year Code, e.g., '15'

YY = Two Digit Work Week Ranging from '01' to

B = Assembly Package Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 11 of this data sheet

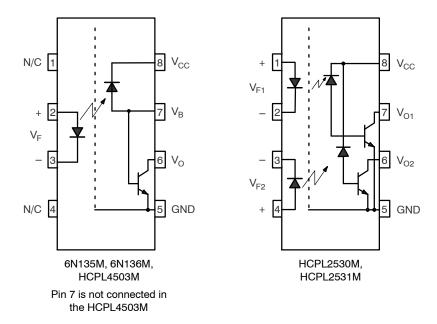


Figure 1. Schematics

SAFETY AND INSULATION RATINGS (As per DIN EN/IEC 60747–5–5, this optocoupler is suitable for "safe electrical insulation" only within the safety limit data. Compliance with the safety ratings shall be ensured by means of protective circuits.)

Parameter	Characteristics	
Installation Classifications per DIN VDE 0110/1.89 Table 1, For Rated Mains Voltage	I–IV	
<300 V _{RMS}		I–IV
	<450 V _{RMS}	I–III
	<600 V _{RMS}	I–III
Climatic Classification	40/100/21	
Pollution Degree (DIN VDE 0110/1.89)	2	
Comparative Tracking Index	175	

Symbol	Parameter	Value	Unit
V_{PR}	Input-to-Output Test Voltage, Method A, $V_{IORM} \times 1.6 = V_{PR}$, Type and Sample Test with $t_m = 10$ s, Partial Discharge < 5 pC	1,335	V _{peak}
	Input-to-Output Test Voltage, Method B, $V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ s, Partial Discharge < 5 pC	1,669	V _{peak}
V_{IORM}	Maximum Working Insulation Voltage	890	V _{peak}
V_{IOTM}	Highest Allowable Over-Voltage	6,000	V_{peak}
	External Creepage	≥8.0	mm
	External Clearance	≥7.4	mm
	External Clearance (for Option TV, 0.4" Lead Spacing)	≥10.16	mm
DTI	Distance Through Insulation (Insulation Thickness)	≥0.5	mm
T _S	Case Temperature (Note 1)	150	°C
I _{S,INPUT}	Input Current (Note 1)	200	mA
P _{S,OUTPUT}	Output Power (Duty Factor ≤ 2.7%) (Note 1)	300	mW
R _{IO}	Insulation Resistance at T _S , V _{IO} = 500 V (Note 1)	>10 ⁹	Ω

^{1.} Safety limit value - maximum values allowed in the event of a failure.

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Value	Unit
T _{STG}	Storage Temperature		-40 to +125	°C
T _{OPR}	Operating Temperature	Operating Temperature		°C
TJ	Junction Temperature		-40 to +125	°C
T _{SOL}	Lead Solder Temperature		260 for 10 s	°C
EMITTER				
I _F (avg)	DC/Average Forward Input Current Each Channel (Note 2)		25	mA
I _F (pk)	Peak Forward Input Current Each Channel (Note 3)	50% Duty Cycle, 1 ms P.W.	50	mA
I _F (trans)	Peak Transient Input Current Each Channel	≤1 μs P.W., 300 pps	1.0	Α
V _R	Reverse Input Voltage Each Channel		5	V
P _D	Input Power Dissipation Each Channel (Note 4)		45	mW
DETECTOR				
I _O (avg)	Average Output Current Each Channel		8	mA
I _O (pk)	Peak Output Current Each Channel		16	mA
V _{EBR}	Emitter-Base Reverse Voltage	6N135M and 6N136M	5	V
V _{CC}	Supply Voltage		-0.5 to 30	V
V _O	Output Voltage		-0.5 to 20	V

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

6N135M and 6N136M

5

100

mΑ

mW

2. Derate linearly above 70°C free-air temperature at a rate of 0.8 mA/°C.

Output Power Dissipation Each Channel (Note 5)

- 3. Derate linearly above 70°C free-air temperature at a rate of 1.6 mA/°C.
- 4. Derate linearly above 70°C free-air temperature at a rate of 0.9 mW/°C.
- 5. Derate linearly above 70°C free-air temperature at a rate of 2.0 mW/°C.

RECOMMENDED OPERATING CONDITIONS

Base Current

I_B

Symbol	Parameter	Min	Max	Unit
V _{CC}	Supply Voltage	4.5	20.0	V
T _A	Ambient Operating Temperature	0	70	°C
I _{FL}	Input Current, Low Level	0	250	μΑ
I _{FH}	Input Current, High Level (Note 6)	6.3	20.0	mA

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

^{6. 6.3} mA is a guard banded value which allows for at least 20% CTR degradation. Initial input current threshold value is 5.0 mA or less.

ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Device	Test Conditions	Min	Тур	Max	Unit
NDIVIDUA	L COMPONENT CHARAC	TERISTICS (V _{CC}	$_{\rm C}$ = 5.0 V, T _A = 0°C to 70°C unless otherwise	e specified	l.)		
EMITTER							
V _F	Input Forward Voltage	All	I _F = 16 mA, T _A = 25°C	_	1.45	1.70	V
		All	I _F = 16 mA	_	-	1.80	
B _{VR}	Input Reverse Breakdown Voltage	All	I _R = 10 μA	5	21	-	V
$\Delta V_F/\Delta T_A$	Temperature Coefficient of Forward Voltage	All	I _F = 16 mA	_	-1.7	-	mV/°C
DETECTO	R			•	•		
	Logic High Output	All	$I_F = 0 \text{ mA}, V_O = V_{CC} = 5.5 \text{ V}, T_A = 25^{\circ}\text{C}$	_	0.0007	0.5	μΑ
I _{OH}	Current	6N135M, 6N136M, HCPL4503M	$I_F = 0 \text{ mA}, V_O = V_{CC} = 15 \text{ V}, T_A = 25^{\circ}\text{C}$	-	0.0019	1	
		All	I _F = 0 mA, V _O = V _{CC} = 15 V	_	-	50	
I _{CCL}	Logic Low Supply Current	6N135M, 6N136M, HCPL4503M	I_F = 16 mA, V_O = Open, V_{CC} = 15 V	-	163	200	μΑ
OOL		HCPL2530M, HCPL2531M	$I_{F1} = I_{F2} = 16 \text{ mA}, V_O = \text{Open},$ $V_{CC} = 15 \text{ V}$	-	-	400	
I _{CCH}	Logic High Supply Current	6N135M, 6N136M,	$I_F = 0$ mA, $V_O = Open$, $V_{CC} = 15$ V	_	0.0004	2	μΑ

TRANSFER CHARACTERISTICS ($T_A = 0^{\circ}C$ to $70^{\circ}C$ unless otherwise specified.)

HCPL4503M HCPL2530M,

HCPL2531M

COUPLED								
CTR	Current Transfer Ratio (Note 7)	6N135M, HCPL2530M	$I_F = 16 \text{ mA}, V_O = 0.4 \text{ V}, V_{CC} = 4.5 \text{ V},$ $T_A = 25^{\circ}\text{C}$		7	38	50	%
		6N136M, HCPL4503M, HCPL2531M			19	38	50	%
		6N135M	$I_F = 16 \text{ mA}, V_{CC} = 4.5 \text{ V}$	V _{OL} = 0.4 V	5	_	-	%
		HCPL2530M		V _{OL} = 0.5 V				
		6N136M, HCPL4503M		V _{OL} = 0.4 V	15	-	-	%
		HCPL2531M		V _{OL} = 0.5 V				
V _{OL}	Logic LOW Output	6N135M	I _F = 16 mA, I _O = 1.1 mA, \	/ _{CC} = 4.5 V,	-	0.12	0.4	V
	Voltage	HCPL2530M	T _A = 25°C				0.5	
		6N136M, HCPL4503M	I_F = 16 mA, I_O = 3 mA, V_C T_A = 25°C	_C = 4.5 V,	-	0.20	0.4	
		HCPL2531M					0.5	
		6N135M, HCPL2530M	$I_F = 16 \text{ mA}, I_O = 0.8 \text{ mA}, V$	/ _{CC} = 4.5 V	-	0.11	0.5	
		HCPL4503M, HCPL2531M	$I_F = 16 \text{ mA}, I_O = 2.4 \text{ mA}, V$	/ _{CC} = 4.5 V	-	0.18	0.5	

 $I_F = 0$ mA, $V_O = Open$, $V_{CC} = 15$ V

ELECTRICAL CHARACTERISTICS (continued)

Symbol	Parameter	Device	Test Conditions	Min	Тур	Max	Unit
SWITCHIN	IG CHARACTERISTICS (T	- A = 0°C to 70°C ι	unless otherwise specified.)				•
t _{PHL}	Propagation Delay Time	6N135M	$T_A = 25^{\circ}C$, $R_L = 4.1 \text{ k}\Omega$, $I_F = 16 \text{ mA}$	_	0.23	1.5	μs
	to Logic LOW	HCPL2530M	(Note 8) (Figure 14)		0.25		
		6N136M, HCPL4503M	T_A = 25°C, R_L = 1.9 k Ω , I_F = 16 mA (Note 9) (Figure 14)	_	0.25	0.8	μs
		HCPL2531M			0.28		
		6N135M, HCPL2530M	R_L = 4.1 kΩ, I_F = 16 mA (Note 8) (Figure 14)	_	-	2.0	μs
		6N136M, HCPL4503M, HCPL2531M	R_L = 1.9 kΩ, I_F = 16 mA (Note 9) (Figure 14)	-	-	1.0	μs
t _{PLH}	Propagation Delay Time	6N135M	$T_A = 25^{\circ}C$, $R_L = 4.1 \text{ k}\Omega$, $I_F = 16 \text{ mA}$	-	0.45	1.5	μs
	to Logic HIGH	HCPL2530M	(Note 8) (Figure 14)		0.29		l
		6N136M, HCPL4503M	T_A = 25°C, R_L = 1.9 k Ω , I_F = 16 mA (Note 9) (Figure 14)	-	0.26	0.8	μs
		HCPL2531M			0.18		
		6N135M, HCPL2530M	R_L = 4.1 kΩ, I_F = 16 mA (Note 8) (Figure 14)	-	-	2.0	μs
		6N136M, HCPL4503M, HCPL2531M	R_L = 1.9 kΩ, I_F = 16 mA (Note 9) (Figure 14)	-	-	1.0	μs
CM _H	Common Mode Transient Immunity	6N135M, HCPL2530M	I_F = 0 mA, V_{CM} = 10 V_{P-P} , R_L = 4.1 kΩ, T_A = 25°C (Note 10) (Figure 15)	-	10,000	-	V/μs
	at Logic High	6N136M, HCPL2531M	I_F = 0 mA, V_{CM} = 10 V_{P-P} , R_L = 1.9 kΩ, T_A = 25°C (Note 10) (Figure 15)	-	10,000	-	
		HCPL4503M	I_F = 0 mA, V_{CM} = 1,500 V_{P-P} , R_L = 4.1 kΩ, T_A = 25°C (Note 10) (Figure 15)	15,000	50,000	-	
CM _L	Common Mode Transient Immunity	6N135M, HCPL2530M	I_F = 16 mA, V_{CM} = 10 V_{P-P} , R_L = 4.1 kΩ, T_A = 25°C (Note 10) (Figure 16)	-	10,000	_	V/μs
	at Logic Low	6N136M, HCPL2531M	I_F = 16 mA, V_{CM} = 10 V_{P-P} , R_L = 1.9 kΩ (Note 10) (Figure 15)	-	10,000	-	
		HCPL4503M	I_F = 16 mA, V_{CM} = 1,500 V_{P-P} , R_L = 4.1 kΩ, T_A = 25°C (Note 10) (Figure 15)	15,000	50,000	ı	

ELECTRICAL CHARACTERISTICS (continued)

Symbol	Parameter	Device	Test Conditions	Min	Тур	Max	Unit
ISOLATIO	SOLATION CHARACTERISTICS (T _A = 25°C, unless otherwise noted.)						
V _{ISO}	Withstand Isolation Test Voltage	All	RH \leq 50%, I _{I-O} \leq 10 μ A t = 1 minute, f = 50 Hz (Note 11) (Note 13)	5,000	-	-	VAC _{RMS}
R _{I-O}	Resistance (Input to Output)	All	V _{I-O} = 500 V _{DC} (Note 11)	-	10 ¹¹	-	Ω
C _{I-O}	Capacitance (Input to Output)	All	$f = 1 \text{ MHz}, V_{I-O} = 0 V_{DC} \text{ (Note 11)}$	-	1	-	pF
I _{I-I}	Input-Input Insulation Leakage Current	HCPL2530M, HCPL2531M	RH \leq 45%, V _{I-I} = 500 V _{DC} , t = 5 s (Note 12)	-	<1	-	nA
R _{I-I}	Input-Input Resistance	HCPL2530M, HCPL2531M	V _{I-I} = 500 V _{DC} (Note 12)	-	10 ¹²	-	Ω
C _{I-I}	Input-Input Capacitance	HCPL2530M, HCPL2531M	f = 1 MHz (Note 12)	-	0.2	=	pF

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 7. Current Transfer Ratio is defined as a ratio of output collector current, I_O, to the forward LED input current, I_F, times 100%.
- 8. The 4.1 k Ω load represents 1 LSTTL unit load of 0.36 mA and 6.1 k Ω pull-up resistor.
- 9. The 1.9 k Ω load represents 1 TTL unit load of 1.6 mA and 5.6 k Ω pull-up resistor.
- 10. Common mode transient immunity in logic high level is the maximum tolerable (positive) dV_{cm}/dt on the leading edge of the common mode pulse signal, V_{CM}, to assure that the output will remain in a logic high state (i.e., V_O > 2.0 V).

 Common mode transient immunity in logic low level is the maximum tolerable (negative) dV_{cm}/dt on the trailing edge of the common mode pulse signal, V_{CM}, to assure that the output will remain in a logic low state (i.e., V_O < 0.8 V).
- 11. Device is considered a two terminal device: pins 1, 2, 3 and 4 are shorted together and pins 5, 6, 7 and 8 are shorted together.
- 12. Measured between pins 1 and 2 shorted together, and pins 3 and 4 shorted together.
- 13.5000 V_{RMS} for 1 minute duration is equivalent to 6000 V_{RMS} for 1 second duration.

TYPICAL PERFORMANCE CURVES

(For single-channel devices; 6N135M, 6N136M, and HCPL4503M.)

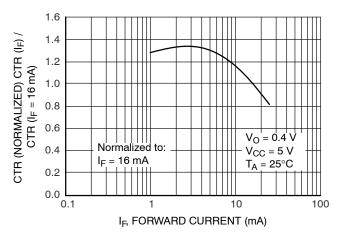


Figure 2. Normalized CTR vs. Forward Current

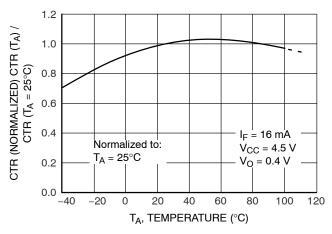


Figure 3. Normalized CTR vs. Temperature

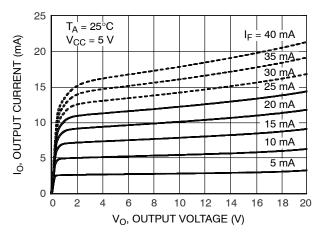


Figure 4. Output Current vs. Output Voltage

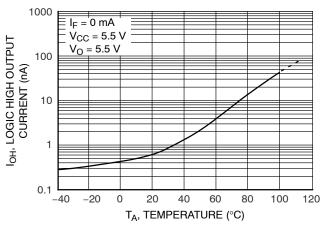


Figure 5. Logic High Output Current vs. Temperature

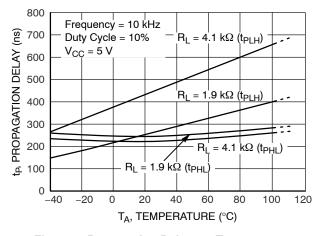


Figure 6. Propagation Delay vs. Temperature

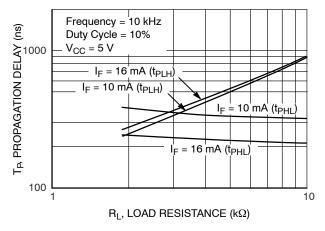


Figure 7. Propagation Delay vs. Load Resistance

TYPICAL PERFORMANCE CURVES

(For dual-channel devices; HCPL2530M and HCPL2531M.)

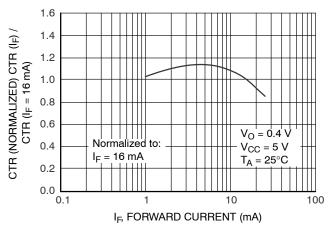


Figure 8. Normalized CTR vs. Forward Current

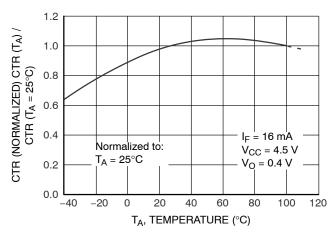


Figure 9. Normalized CTR vs. Temperature

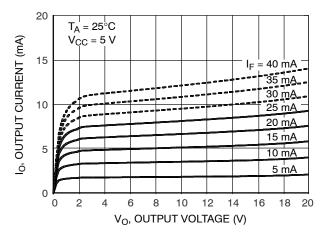


Figure 10. Output Current vs. Output Voltage

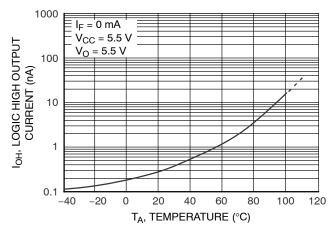


Figure 11. Logic High Output Current vs.
Temperature

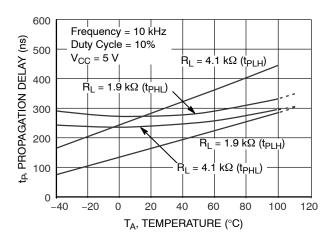


Figure 12. Propagation Delay vs. Temperature

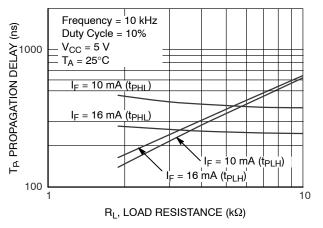
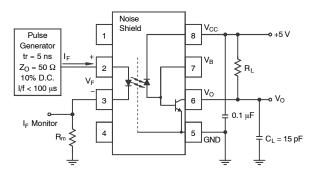
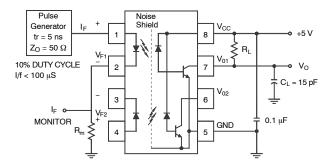


Figure 13. Propagation Delay vs. Load Resistance





Test Circuit for 6N135M, 6N136M, and HCPL4503M

Test Circuit for HCPL2530M and HCPL2531M

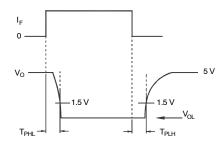
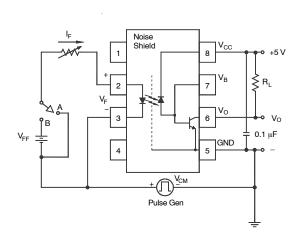
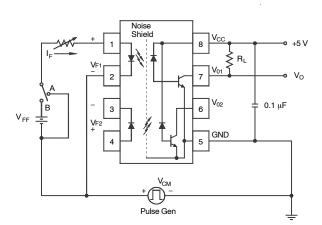


Figure 14. Switching Time Test Circuit



Test Circuit for 6N135M, 6N136M, and HCPL4503M



Test Circuit for HCPL2530M and HCPL2531M

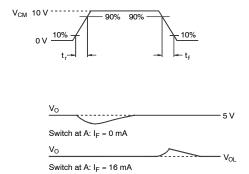
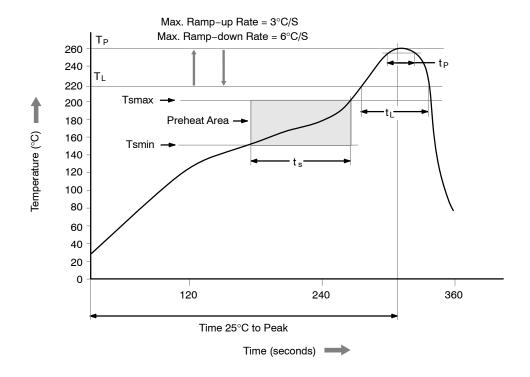


Figure 15. Common Mode Immunity Test Circuit



Profile Freature	Pb-Free Assembly Profile
Temperature Min. (Tsmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (t _S) from (Tsmin to Tsmax)	60 to 120 s
Ramp-up Rate (t _L to t _P)	3°C/second maximum
Liquidous Temperature (T _L)	217°C
Time (t _L) Maintained Above (T _L)	60 to 150 s
Peak Body Package Temperature	260°C +0°C / -5°C
Time (t _P) within 5°C of 260°C	30 s
Ramp-down Rate (T _P to T _L)	6°C/s maximum
Time 25°C to Peak Temperature	8 minutes maximum

Figure 16. Reflow Profile

ORDERING INFORMATION

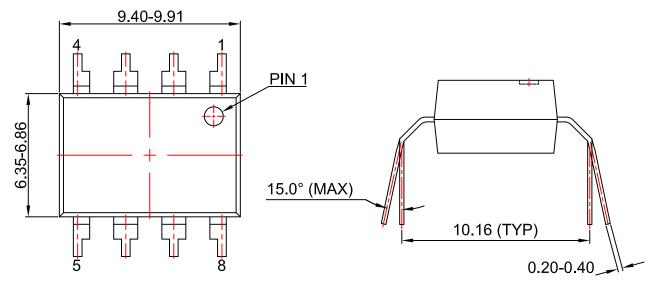
Part Number	Package	Shipping [†]
6N135M	PDIP8 9.655x6.61, 2.54P DIP 8–Pin	50 Units / Tube
6N135SM	PDIP8 GW SMT 8-Pin (Lead Bend)	50 Units / Tube
6N135SDM	35SDM PDIP8 GW SMT 8-Pin (Lead Bend)	
6N135VM	PDIP8 9.655x6.61, 2.54P DIP 8-Pin, DIN IEC60747-5-5 Option	50 Units / Tube
6N135SVM	PDIP8 GW SMT 8-Pin (Lead Bend), DIN EN/IEC 60747-5-5 Option	50 Units / Tube
6N135SDVM	PDIP8 GW SMT 8-Pin (Lead Bend), DIN EN/IEC 60747-5-5 Option	1,000 / Tape and Reel
6N135TVM	PDIP8 6.6x3.81, 2.54P DIP 8-Pin, 0.4" Lead Spacing, DIN EN/IEC 60747-5-5 Option	50 Units / Tube
6N135TSVM	PDIP8 GW SMT 8-Pin, 0.4" Lead Spacing, DIN EN/IEC 60747-5-5 Option	50 Units / Tube
6N135TSR2VM	PDIP8 GW SMT 8-Pin, 0.4" Lead Spacing, DIN EN/IEC 60747-5-2 Option	1,000 / Tape and Reel

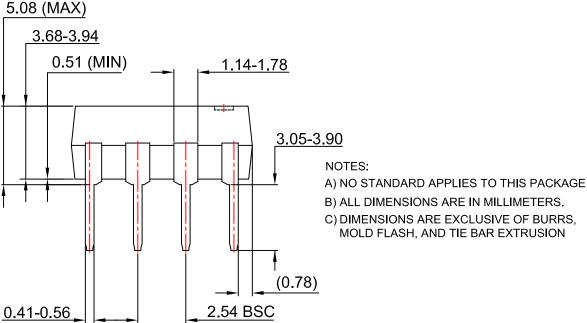
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

NOTE: The product orderable part number system listed in this table also applies to the 6N136M, HCPL4503M, HCPL2530M and HCPL2531M product families.

PDIP8 6.6x3.81, 2.54P CASE 646BW ISSUE O

DATE 31 JUL 2016

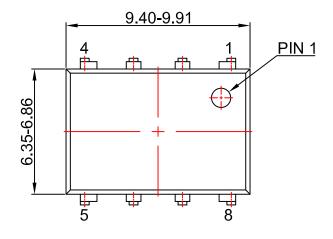


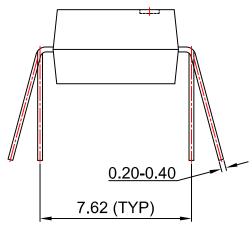


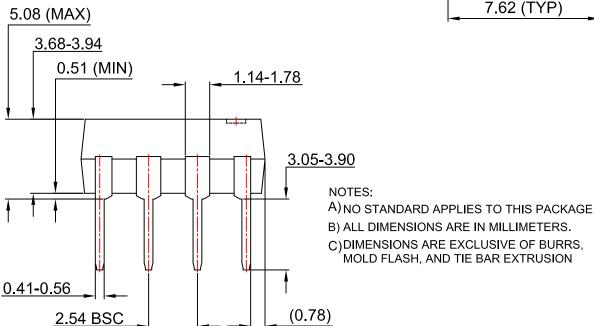
DOCUMENT NUMBER:	98AON13445G	Electronic versions are uncontrolled except when accessed directly from the Document Repository Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	PDIP8 6.6X3.81, 2.54P		PAGE 1 OF 1	

PDIP8 9.655x6.6, 2.54P CASE 646CQ ISSUE O

DATE 18 SEP 2017



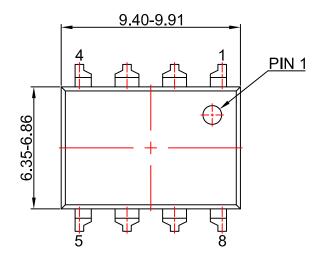


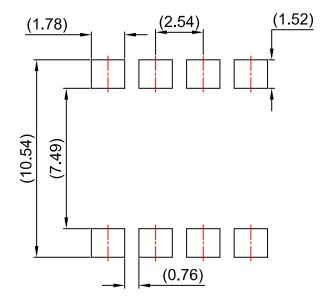


DOCUMENT NUMBER:	98AON13446G	Electronic versions are uncontrolled except when accessed directly from the Document Repository Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	PDIP8 9.655X6.6, 2.54P		PAGE 1 OF 1	

PDIP8 GW CASE 709AC ISSUE O

DATE 31 JUL 2016





5.08 (MAX)

3.68-3.94

0.51 (MIN)

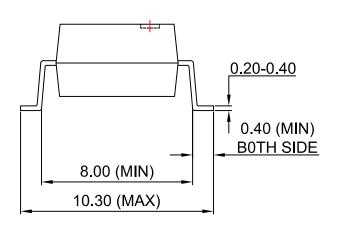
1.14-1.78

(0.78)

2.54BSC

0.41-0.56

LAND PATTERN RECOMMENDATION

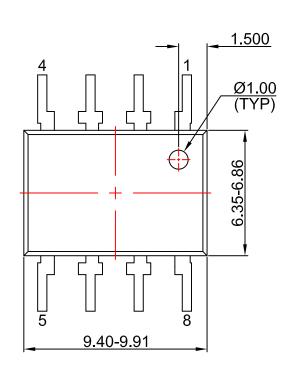


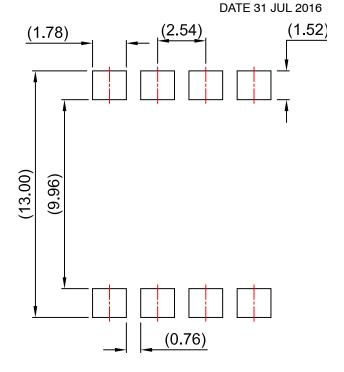
NOTES:

- A) NO STANDARD APPLIES TO THIS PACKAGE
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSION

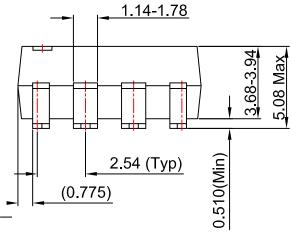
DOCUMENT NUMBER:	98AON13447G	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	PDIP8 GW		PAGE 1 OF 1

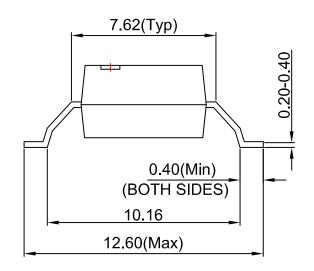
PDIP8 GW CASE 709AD ISSUE O





LAND PATTERN RECOMMENDATION





NOTES:

- A) NO STANDARD APPLIES TO THIS PACKAGE
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSION

DOCUMENT NUMBER:	98AON13448G	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	PDIP8 GW		PAGE 1 OF 1

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800–282–9855 Toll Free USA/Canada

Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative